

U. S. DEPARTMENT OF COMMERCE
Sheet 1 of 1

PATENT AND TRADEMARK OFFICE

LIST OF REFERENCES CITED BY APPLICANT

Atty Docket No.: 4925-35

Filing Date: concurrently

Serial No.: n/a

Group Art:

Applicant: Heikki RAUTILLA et al.

JCS42 U.S. PTO
09/612870
07/10/00

U.S. PATENT DOCUMENTS

*Ex. Intls.		Document No.	Date	Name	Class	Subclass	Filing Date
DS	AA	5,592,551	1/07/97	Lett, et al.	380	20	
DS	AB	5,812,931	9/22/98	Yuen	455	5.1	
DS	AC	5,898,919	4/27/99	Yuen	455	420	
DS	AD	5,990,882	11/23/99	Heinonen, et al.	345	327	
	AE						

FOREIGN PATENT DOCUMENTS

*Ex. Intls.		Document No.	Date	Country	Name	Class	Subclass	Translation Yes/No
	AF							
	AG							
	AH							
	AI							

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

	AJ		
	AK		
	AL		

EXAMINER:

Dominic Sabarelli

DATE CONSIDERED:

7 April 2004

* EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



LIST OF REFERENCES CITED BY APPLICANT

Atty Docket No.: 4925-35
Serial No.: 09/612,870
Applicant: Heikki RAUTILA et al.

Filing Date: July 10, 2000
Group Art: 2711

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U.S. PATENT DOCUMENTS

*Ex. Intls.		Document No.	Date	Name	Class	Subclass	Filing Date
	AA						
	AB						
	AC						
	AD						
	AE						

FOREIGN PATENT DOCUMENTS

*Ex. Intls.		Document No.	Date	Country	Name	Class	Subclass	Translation Yes/No
DS	AF	EP 0 837 599 A2	04/22/98	EPO	Eyer et al.			In English
DS	AG	WO 97/31476	08/28/97	PCT	Perkes			In English
	AH							
	AI							
	AJ							

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

	AK		
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EXAMINER: Dominic Scharelli

DATE CONSIDERED: 7 April 2004

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U.S. PATENT DOCUMENTS

*Ex. Intls.		Document No.	Date	Name	Class	Subclass	Filing Date
DS	AA	5,600,364	02/04/97	Hendricks et al.	348	1	12/02/93
DS	AB	5,083,272	01/21/1992	Walker et al.	364	412	11/02/1988
	AC						
	AD						
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FOREIGN PATENT DOCUMENTS

*Ex. Intls.		Document No.	Date	Country	Name	Class	Subclass	Translation Yes/No
DS	AF	WO 99/04568	01/28/99	PCT	Ferris et al.	H04N	7/173	Yes
DS	AG	WO 99/42964	08/26/99	PCT	Stadelmann	G07F	17/32	Yes
DS	AH	WO 00/05889	02/03/00	PCT	Ellis et al.	H04N	7/16	Yes
	AI							
	AJ							

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

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EXAMINER: Dominic SatorelliDATE CONSIDERED: 7 April 2004

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